## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LIN ET AL. | Examiner | Art Unit | Dang T Nguyen | 2824 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
•	Α	US-6,469,926 B1	10-2002	Chen, Eugene Youjun	365/158
	В	US-US 20040257868A1	12-2004	Tang, Denny Duan-Lee	365/173
	С	US-6,166,948 A	12-2000	Parkin et al.	365/173
	D	US-2002/0054462 A1	05-2002	Sun et al.	360/324.2
	E	US-6,211,559 B1	04-2001	Zhu et al.	257/421
	F	US-6,185,080 B1	02-2001	Gill, Hardayal Singh	360/324.2
	G	US-			
-	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				·	
	0	÷				
	Р					
	Q				*	
	R					
,	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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